



CBR-SMD RF COG, Ceramic, 9.9 pF, +/-0.1 pF, 500 VDC, COG, SMD, Fixed, RF, Ultra High Q, Low ESR, Class I, 0805



| General Information | |
|--------------------------|---|
| Series | CBR-SMD RF COG |
| Style | SMD Chip |
| Description | SMD, Fixed, RF, Ultra High Q, Low ESR, Class I |
| Features | Ultra High Q, Low ESR, Class I |
| RoHS | Yes |
| Termination | Tin |
| Marking | No |
| AEC-Q200 | No |
| Typical Component Weight | 12.03 mg |
| Notes | Solder Wave or Solder Reflow. |
| Shelf Life | 78 Weeks |
| MSL | 1 |

| Dimensions | |
|------------|-----------------|
| Chip Size | 0805 |
| L | 2mm +/-0.2mm |
| W | 1.25mm +/-0.2mm |
| T | 0.85mm +/-0.1mm |
| В | 0.5mm +/-0.2mm |

| Packaging Specifications | |
|--------------------------|--------------------------|
| Packaging | T&R, 180mm, Plastic Tape |
| Packaging Quantity | 4000 |

| Specifications | |
|--|--|
| Capacitance | 9.9 pF |
| Tolerance | +/-0.1 pF |
| /oltage DC | 500 VDC |
| Dielectric Withstanding Voltage | 750 VDC |
| emperature Range | -55/+125°C |
| Temp. Coefficient | COG |
| Dissipation Factor | 0.167% |
| Aging Rate | 0% Loss/Decade Hour |
| nsulation Resistance | 10 GOhms |
| Quality Factor | 598 |
| /oltage DC Dielectric Withstanding Voltage Temperature Range Temp. Coefficient Dissipation Factor Aging Rate Insulation Resistance | 500 VDC 750 VDC -55/+125°C COG 0.167% 0% Loss/Decade Hour 10 GOhms |

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